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PATENT NUMBER

யித் யாயால் Patent Application

OSSIGNIENT ALERT APPRICATION

PATENT DATE

SCANNED CHAP Q.A. HT

*APPLICATION NO. 09/,668320	CONT/PRIOR	CLASS 703	SUBCLASS Z	2123	EXAMINER FREJD	<u></u>
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ራ የርዝልሃቸውs Alpert Anirudh Devgan Chandramouli Kashyap

Method and system for determining an interconnect delay utilizing (KáñYeffective capacitance metric (ECM) signal delay model

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PTO-2040 12/99

	ISSUING CLASSIFICATION											
-	ORIGINAL			CROSS REFERENCE(S)								
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Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.	
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